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**Graphene field-effect transistors for RF applications<sup>1</sup>**

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There has been growing interest in graphene as a replacement for III-V materials in MMIC applications because of its high mobility, its potential for high saturation velocity, and its nearly perfect two-dimensional electrostatics. We present results from the first experimental high-frequency measurements of graphene field-effect transistors (GFETs), demonstrating an  $f_T$  of 14.7 GHz for a 0.5- $\mu\text{m}$ -length device with a 30-nm-thick  $\text{HfO}_2$  top-gate. Despite  $I_{on}/I_{off} \sim 7$ , high transconductances ( $>833 \mu\text{S}/\mu\text{m}$ ) and current saturation are achieved. We present detailed measurement and analysis of velocity saturation in GFETs, demonstrating the potential for velocities approaching  $10^8 \text{cm}/\text{sec}$  and the effect of an ambipolar channel on current-voltage characteristics. We find that the saturation velocity is sheet-carrier dependent and limited by interfacial phonon scattering from the  $\text{SiO}_2$  substrate upon which the graphene is fabricated.

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